

# **EMC Test Report**

Report No.: AGC00550220603EE01

**PRODUCT DESIGNATION**: smartwatch

BRAND NAME : Blackview, IOWODO, FeipuQu

R1, R10, R10Pro, R20, R20Pro, R30, R30Pro, R40, R40Pro,

**MODEL NAME** : R50, R50Pro, R60, R60Pro, R70, R70Pro, R80, R80Pro, R90,

R90Pro

**APPLICANT**: Shenzhen Hairuichuang Technology Co., Ltd.

**DATE OF ISSUE** : Aug. 03, 2022

**STANDARD(S)** : ETSI EN 301 489-1 V2.2.3 (2019-11) : ETSI EN 301 480-1 7 V2.2.4 (2020-2020)

ETSI EN 301 489-17 V3.2.4 (2020-09)

REPORT VERSION : V1.0

Attestation of Global Compliance (Shenzhen) Co., Ltd





Page 2 of 49

## **REPORT REVISE RECORD**

Report Version	Revise Time	Issued Date	Valid Version	Notes
V1.0	/	Aug. 03, 2022	Valid	Initial release

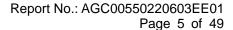


## **TABLE OF CONTENTS**

1. TEST REPORT CERTIFICATION	6
2. GENERAL INFORMATION	7
2.1. DESCRIPTION OF EUT	7
2.2. OBJECTIVE	
2.3. TEST STANDARDS AND RESULTS	
2.4. TEST ITEMS AND THE RESULTS	
2.5. ENVIRONMENTAL CONDITIONS	9
3. TEST MODE DESCRIPTION	10
4. MEASUREMENT UNCERTAINTY	11
5. SUPPORT EQUIPMENT	11
6. IDENTIFICATION OF THE RESPONSIBLE TESTING LOCATION	12
7. RADIATED DISTURBANCE MEASUREMENT	14
7.1. LIMITS OF RADIATED DISTURBANCES	14
7.2. TEST PROCEDURE	14
7.3. BLOCK DIAGRAM OF TEST SETUP	15
7.4. TEST RESULT	16
8. MAINS TERMINAL DISTURBANCE VOLTAGE MEASUREMENT	20
8.1. LIMITS OF MAINS TERMINAL DISTURBANCE VOLTAGE	20
8.2. TEST PROCEDURE	20
8.3. TEST SETUP	
8.4. TEST RESULT	21
9. HARMONIC CURRENT MEASUREMENT	24
9.1. LIMITS OF HARMONIC CURRENT	24
9.2. TEST PROCEDURE	24
9.3. TEST SETUP	
9.4. TEST RESULT	25
10. VOLTAGE FLUCTUATIONS AND FLICK MEASUREMENT	26
10.1. LIMITS OF VOLTAGE FLUCTUATIONS AND FLICK	26
10.2. TEST PROCEDURE	26

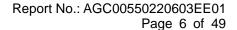


10.3. TEST SETUP	26
10.4. TEST RESULT	26
11. IMMUNITY TEST	27
11.1. DESCRIPTION OF PERFORMANCE CRITERIA	27
11.2. GENERAL PERFORMANCE CRITERIA	
12. ELECTROSTATIC DISCHARGE IMMUNITY TEST	29
12.1 TEST SPECIFICATION	29
12.2 TEST PROCEDURE	29
12.3 TEST SETUP	30
12.4 TEST RESULT	
12.5 PERFORMANCE	
13. RADIATED, RADIO FREQUENCY ELECTROMAGNETIC FIELD IMMUNITY TEST	33
13.1. TEST SPECIFICATION	33
13.2. TEST PROCEDURE	33
13.3. TEST SETUP	34
13.4. TEST RESULT	35
13.5. PERFORMANCE	35
14. ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST	36
14.1. TEST SPECIFICATION	36
14.2. TEST PROCEDURE	36
14.3. TEST SETUP	36
14.4. TEST RESULT	37
14.5. PERFORMANCE	37
15. SURGE IMMUNITY TEST	38
15.1. TEST SPECIFICATION	38
15.2. TEST PROCEDURE	38
15.3. TEST SETUP	38
15.4. TEST RESULT	39
15.5. PERFORMANCE	
16. IMMUNITY TO CONDUCTED DISTURBANCES INDUCED BY RF FIELDS	40
16.1. TEST SPECIFICATION	40
16.2. TEST PROCEDURE	40





16.3. TEST SETUP	40
16.4. TEST RESULT	41
16.5. PERFORMANCE	41
17. VOLTAGE DIPS AND SHORT INTERRUPTIONS IMMUNITY TEST	42
17.1. TEST SPECIFICATION	42
17.2. TEST PROCEDURE	42
17.3. TEST SETUP	
17.4. TEST RESULT	
17.5. PERFORMANCE	43
APPENDIX A: PHOTOGRAPHS OF TEST SETUP	44
APPENDIX B: PHOTOGRAPHS OF EUT	49





## 1. TEST REPORT CERTIFICATION

Shenzhen Hairuichuang Technology Co., Ltd.			
Room 2001, Building A, Weidonglong Business Building, No. 2125, Meilong Avenue, Longhua District, Shenzhen, China			
Shenzhen Hairuichuang Technology Co., Ltd.			
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Shenzhen Hairuichuang Technology Co., Ltd.			
Room 2001, Building A, Weidonglong Business Building, No. 2125, Meilong Avenue, Longhua District, Shenzhen, China			
smartwatch			
Blackview, IOWODO, FeipuQu			
R1			
R10, R10Pro, R20, R20Pro, R30, R30Pro, R40, R40Pro, R50, R50Pro, R60, R60Pro, R70, R70Pro, R80, R80Pro, R90, R90Pro			
All the series models are the same as the test model except for the model names.			
Jul. 25, 2022 to Aug. 03, 2022			
None			
Normal			
Pass			
AGCRT-EC-EMC			

We, Attestation of Global Compliance (Shenzhen) Co., Ltd., hereby certify that the submitted samples of the above item, as detailed in chapter 2.1 of this report, has been tested in our facility. The test record, data evaluation and test configuration represented herein are true and accurate accounts of measurements of the sample's EMC characteristics under the conditions herein specified.

Prepared By	Bibo zhay	
	Bibo Zhang (Project Engineer)	Aug. 03, 2022
Reviewed By Colin Lin		
	Calvin Liu (Reviewer)	Aug. 03, 2022
Approved By	Max Zhang	
	Max Zhang (Authorized Officer)	Aug. 03, 2022

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Tel: +86-755 2523 4088 E-mail: agc@agccert.com Web: http://www.agccert.com/



Page 7 of 49

## 2. GENERAL INFORMATION

## 2.1. DESCRIPTION OF EUT

Details of technical specification refer to the description in follows:

Transmitter/Receiver (TX/RX)

	,	
Operating Frequency	2.402 GHz to 2.480GHz	
Modulation	BR: □GFSK, EDR: □π /4-DQPSK, □8DPSK BLE: □GFSK 1Mbps □GFSK 2Mbps	
Bluetooth Version	V5.0	
Hardware Version	V02	
Software Version	V1.0	
Antenna designation	FPC Antenna	
Number of channels	40	
Antenna Gain	-6.91dBi	
Power Supply	DC 3.7V by battery or DC 5V by adapter	



Page 8 of 49

## 2.2. OBJECTIVE

Perform Electro Magnetic Interference (EMI) and Electro Magnetic Susceptibility (EMS) tests for CE Marking.

## 2.3. TEST STANDARDS AND RESULTS

The EUT has been tested according to ETSI EN 301 489-1 V2.2.3 (2019-11) and ETSI EN 301 489-17 V3.2.4 (2020-09).

	,	
ETSI EN 301 489-1	ElectroMagnetic Compatibility (EMC) standard for radio equipment and services; Part 1: Common technical requirements; Harmonised Standard for ElectroMagnetic	
	Compatibility.	
	ElectroMagnetic Compatibility (EMC) standard for radio equipment and services;	
ETSI EN 301 489-17	Part 17: Specific conditions for Broadband Data Transmission Systems;	
	Harmonised Standard for ElectroMagnetic Compatibility	

### 2.4. TEST ITEMS AND THE RESULTS

No.	Basic Standard	Test Type	Result	
EMISSION (EN 301 489-1 §7.1)				
1	EN 55032	5032 Radiated emission		
2	EN 55032	Conducted emission, AC ports	PASS	
3	EN 55032	Conducted emission, Telecom ports	N/A	
4	EN 61000-3-2	Harmonic current emissions	N/A	
5	EN 61000-3-3	Voltage fluctuations & flicker	PASS	
IMMUNITY (EN 301 489-1 §7.2)				
6	EN 61000-4-2	Electrostatic discharge immunity	PASS	
7	EN 61000-4-3	Radiated RF electromagnetic field immunity	PASS	
8	EN 61000-4-4	Electrical fast transient/burst immunity	PASS	
9	9 ISO 7637-1, -2 Transients and surges, DC ports		N/A	
10	0 EN 61000-4-5 Surge immunity, AC ports, Telecom ports		PASS	
11	EN 61000-4-6	Immunity to conducted disturbances induced by RF fields	PASS	
12	EN 61000-4-11	Voltage dips and short interruptions immunity	PASS	

Note: 1. N/A- Not Applicable.

The latest versions of basic standards are applied.



Page 9 of 49

## 2.5. ENVIRONMENTAL CONDITIONS

During the measurement the environmental conditions were within the listed ranges:

- Temperature: 15-35°C

- Relative humidity: 30-60 %

- Atmospheric pressure: 86-106 kPa



Page 10 of 49

## 3. TEST MODE DESCRIPTION

C. 1201 MODE DECORM TION				
TEST MODE DESCRIPTION				
NO.	EMI TEST MODE DESCRIPTION	WORST		
1	Charging+BT Mode	V		
2	BT Mode	-		
NO.	EMS TEST MODE DESCRIPTION	WORST		
1	Charging+BT Mode	V		
2	BT Mode	-		
Note: 1. V means EMI worst mode.				
2. All modes have been tested and only the worst mode test data recorded in the test report.				

## I/O Port Information (⊠Applicable □Not Applicable)

I/O Port of EUT				
I/O Port Type Number Cable Description Tested With				

Note: All the above "--" means that EUT has no cable.



Page 11 of 49

## 4. MEASUREMENT UNCERTAINTY

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in measurement" (GUM) published by CISPR and ANSI.

- Uncertainty of Radiated Emission, Uc = ±2.9dB
- Uncertainty of Radiated Emission below 1GHz, Uc = 3.8 dB
- Uncertainty of Radiated Emission above 1GHz, Uc = ±4.9 dB

## 5. SUPPORT EQUIPMENT

Device Type	Manufacturer	Model Name	Data Cable
adapter	jinbaotong	K-T10E0502000E	
Xiaomi phone	Xiaomi	Mi 10	

Note: 1."-- "means no any support device during testing.

2. All the cables were provided by AGC Lab.



Page 12 of 49

## 6. IDENTIFICATION OF THE RESPONSIBLE TESTING LOCATION

Site	Attestation of Global Compliance (Shenzhen) Co., Ltd
Location	1-2/F, Building 19, Junfeng Industrial Park, Chongqing Road, Heping Community, Fuhai Street, Bao'an District, Shenzhen, Guangdong, China

## **TEST EQUIPMENT OF CONDUCTED EMISSION TEST**

Equipment	Equipment Manufacturer Model S/N		S/N	Cal. Date	Cal. Due	
Test Receiver	est Receiver R&S ESPI 101206		Mar. 28, 2022	Mar. 27, 2023		
LISN	R&S	ESH2-Z5	100086	Jun. 08, 2022	Jun. 07, 2023	

#### **TEST EQUIPMENT OF RADIATED EMISSION TEST**

Equipment	uipment Manufacturer Model S/N		Cal. Date	Cal. Due	
Test Receiver	R&S	ESCI	10096	Mar. 28, 2022	Mar. 27, 2023
ANTENNA	SCHWARZBECK	VULB9168	494	Jan. 08, 2021	Jan. 07, 2023
Double-Ridged	ETS LINDGREN	3117	00034609	Apr. 23, 2021	Apr. 22, 2023
Waveguide Horn					
EXA Signal Analyzer	Aglient	N9010A	MY53470504	Nov. 17, 2021	Nov. 16, 2022

## **TEST EQUIPMENT OF ESD TEST**

Equipment	Manufacturer	Model S/N		Cal. Date	Cal. Due	
ESD Simulator	EM Test	NSG 438	782	Jan. 03, 2022	Jan. 02, 2023	

## TEST EQUIPMENT OF POWER HARMONICS / VOLTAGE FLUCTUATION / FLICKER TEST

Equipment	quipment Manufacturer Model S/N		Cal. Date	Cal. Due	
Signal Conditioning Unit	Schaffner	CCN1000-1	72431	Jun. 23,2022	Jun. 22,2023
AC Source	Schaffner	NSG 1007	56825	Jun. 08,2022	Jun. 07,2023

## **TEST EQUIPMENT OF SURGE/EFT/DIPSTEST**

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due
EFT Surge	Schoffnor	Modula 6150	34437	Jun. 23,2022	Jun. 22,2023
Generator	Schaffner				



Page 13 of 49

## **TEST EQUIPMENT OF RS IMMUNITY TEST**

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due
Signal Generator	R&S	E4421B	MY43351603	Mar. 04, 2022	Mar. 03, 2023
POWER SENSOR	R&S	URV5-Z4	100124	Apr. 26, 2021	Apr. 25, 2023
POWER METER	R&S	NRVD	8323781027	Apr. 26, 2021	Apr. 25, 2023
POWER AMPLIFIER	KALMUS	7100LC	04-02/17-06-	N/A	N/A
FOWER AWIFEII IER			001	IN/A	IN/A
RF AMPLIFIER	Milmega	AS0104-55_55	1004793	N/A	N/A
Double-Ridged	ETS LINDGREN	3117	00034609	Apr. 23, 2021	A== 00 0000
Waveguide Horn	E 13 LINDGREN	3117	00034609	Apr. 23, 2021	Apr. 22, 2023
ANTENNA	SCHWARZBECK	VULB9168	494	Jan. 08,2021	Jan. 07,2023

## TEST EQUIPMENT OF CS IMMUNITY TEST

Equipment	Manufacturer	Model	Model S/N		Cal. Due	
Power Amplifier	AR	75A250	18464	N/A	N/A	
CDN	ZHINAN	ZN3751	15004	Sep. 03, 2020	Sep. 02, 2022	
6dB attenuator	or ZHINAN E-002 N/A S		Sep. 03, 2020	Sep. 02, 2022		
Electromagnetic	Luthi	EM101	35773	Aug. 25,2020	Aug. 24,2022	
Injection Clamp	23011	2111101	33773	7 tag: 20,2020	7 tag. 2 1,2022	
Power Sensor	R&S	URV5-Z4	100124	Apr. 26, 2021	Apr. 25, 2023	
Power Meter	R&S	NRVD	8323781027	Apr. 26, 2021	Apr. 25, 2023	
SIGNAL	R&S	E4421B	MY43351603	Mar. 04, 2022	Mar. 03, 2023	
GENERATOR	NXS	L4421D	101145551005	Iviai. 04, 2022	Mai. 03, 2023	



Page 14 of 49

## 7. RADIATED DISTURBANCE MEASUREMENT

#### 7.1. LIMITS OF RADIATED DISTURBANCES

Limits for radiated disturbance 30M to1 GHz at a measurement distance of 3 m

Frequency range (MHz)	Quasi peak limits(dBuV/m), for Class B ITE, at 3m measurement distance
30 - 230	40
230 - 1000	47

#### Limits for radiated disturbance above 1 GHz at a measurement distance of 3 m

Fraguency range (MU=)	Limits (dBuV/m), Class B ITE				
Frequency range (MHz)	Peak	Average			
1000-3000MHz	70	50			
3000-6000MHz	74	54			

Note: 1. The lower limit shall apply at the transition frequency.

2. Additional provisions may be required for cases where interference occurs.

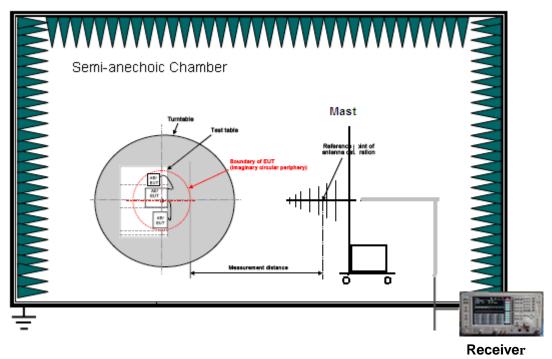
#### 7.2. TEST PROCEDURE

- (1). The EUT was placed on the top of an insulating table 0.8 meters above the ground at a semi-anechoic chamber. The table was rotated 360 degrees to determine the position of the highest radiation.
- (2). The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- (3). The antenna is a broadband antenna, and its height is varied from 1 to 4 meter above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- (4). For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to the heights from 1 to 4 meters and the ratable table was turned from 0 degrees to 360 degrees to find the maximum reading.

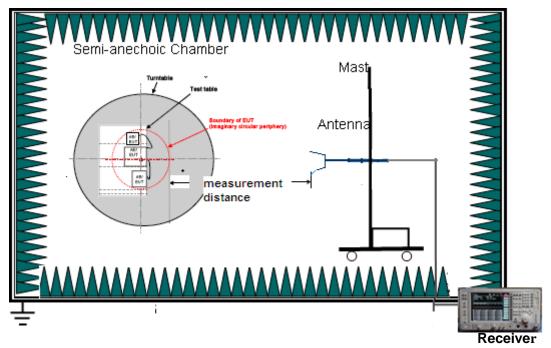


## 7.3. BLOCK DIAGRAM OF TEST SETUP

#### Radiated Disturbance below 1 GHz



## Radiated Disturbance above 1 GHz



For the actual test configuration, please refer to the related item-Photographs of the Test Configuration.

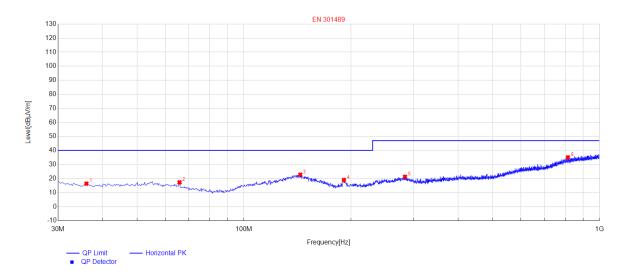


## 7.4. TEST RESULT

The test modes were carried out for all modes.

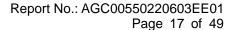
The worst test mode of the EUT was Mode 1, and its test data was showed as the follow:

## RADIATED EMISSION BELOW 1GHz-HORIZONTAL



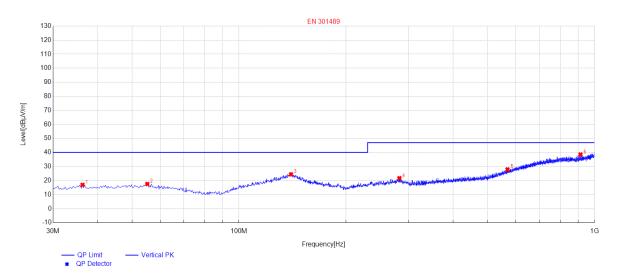
NO.	Freq.	Level	Factor	Limit	Margin	Height	Angle	Dolority
NO.	[MHz]	[dBµV/m]	[dB]	[dBµV/m]	[dB]	[cm]	[°]	Polarity
1	36.0625	16.40	10.73	40.00	23.60	100	265	Horizontal
2	65.89	17.30	9.93	40.00	22.70	100	342	Horizontal
3	143.975	22.78	17.29	40.00	17.22	100	50	Horizontal
4	191.02	19.02	11.58	40.00	20.98	100	271	Horizontal
5	283.655	21.31	16.04	47.00	25.69	100	206	Horizontal
6	814.73	35.10	29.41	47.00	11.90	100	122	Horizontal

**RESULT: PASS** 



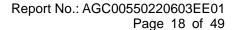


## RADIATED EMISSION BELOW 1GHz- VERTICAL



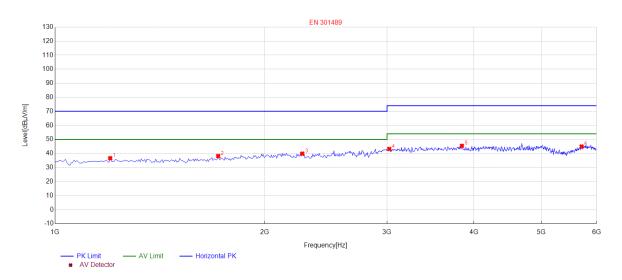
NO	Freq.	Level	Factor	Limit	Margin	Height	Angle	Dolovity
NO.	[MHz]	[dBµV/m]	[dB]	[dBµV/m]	[dB]	[cm]	[°]	Polarity
1	36.305	16.96	10.73	40.00	23.04	100	171	Vertical
2	55.22	17.57	11.27	40.00	22.43	100	17	Vertical
3	140.095	24.43	19.86	40.00	15.57	100	356	Vertical
4	282.685	21.68	16.10	47.00	25.32	100	22	Vertical
5	569.0775	27.95	22.92	47.00	19.05	100	289	Vertical
6	913.185	38.52	31.91	47.00	8.48	100	70	Vertical

**RESULT: PASS** 



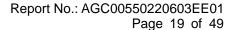


## RADIATED EMISSION ABOVE 1GHz - HORIZONTAL



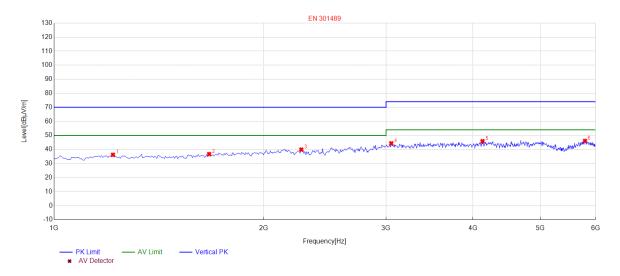
NO	Freq.	Level	Factor	Limit	Margin	Height	Angle	Dolovitu
NO.	[MHz]	[dBµV/m]	[dB]	[dBµV/m]	[dB]	[cm]	[°]	Polarity
1	1200.2002	36.63	-19.88	70.00	33.37	100	280	Horizontal
2	1715.7157	38.20	-18.24	70.00	31.80	100	280	Horizontal
3	2266.2663	39.86	-14.48	70.00	30.14	100	190	Horizontal
4	3022.022	43.19	-11.16	74.00	30.81	100	330	Horizontal
5	3842.8428	45.44	-8.60	74.00	28.56	100	330	Horizontal
6	5709.7097	44.92	-5.88	74.00	29.08	100	320	Horizontal

**RESULT: PASS** 





## RADIATED EMISSION ABOVE 1GHz - VERTICAL



NO.	Freq.	Level	Factor	Limit	Margin	Height	Angle	Polarity
110.	[MHz]	[dBµV/m]	[dB]	[dBµV/m]	[dB]	[cm]	[°]	rolanty
1	1215.2152	36.25	-19.88	70.00	33.75	100	290	Vertical
2	1670.6707	36.73	-18.60	70.00	33.27	100	200	Vertical
3	2266.2663	39.94	-14.48	70.00	30.06	100	300	Vertical
4	3052.0521	44.40	-11.07	74.00	29.60	100	330	Vertical
5	4128.1281	45.91	-7.95	74.00	28.09	100	50	Vertical
6	5794.7948	46.09	-5.59	74.00	27.91	100	200	Vertical

**RESULT: PASS** 



Page 20 of 49

## 8. MAINS TERMINAL DISTURBANCE VOLTAGE MEASUREMENT

## 8.1. LIMITS OF MAINS TERMINAL DISTURBANCE VOLTAGE

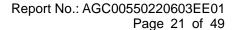
Eroguanov rango (MHz)	Limits (dBuV) Class B ITE			
Frequency range (MHz)	Quasi-peak	Average		
0.15 - 0.50	66 to 56	56 to 46		
0.50 - 5	56	46		
5 - 30	60	50		

Note: 1. The lower limit shall apply at the transition frequencies.

2. The limit decreases linearly with the logarithm of the frequency in the range 0.15MHz to 0.50MHz.

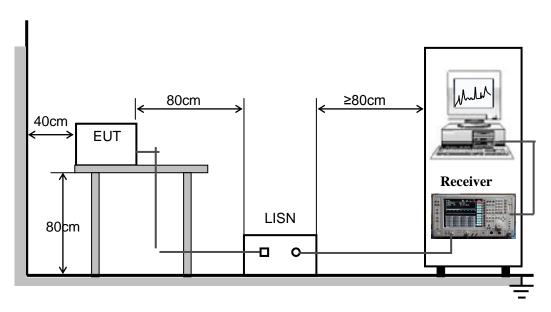
## **8.2. TEST PROCEDURE**

- (1) The EUT was placed 0.4 meters from the conducting wall of shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN). The LISN provide  $50\Omega/50\mu H$  of coupling impedance for the measuring instrument.
- (2) Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
- (3)The frequency range from 150 kHz to 30 MHz was searched. Emission levels over 20dB under the prescribed limits are not reported.





## 8.3. TEST SETUP



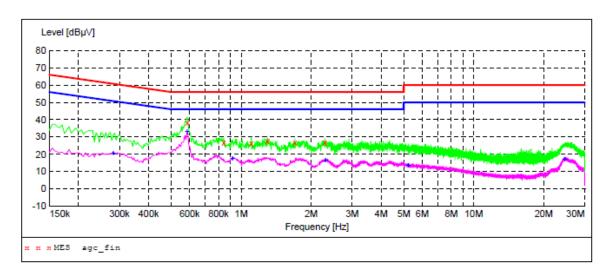
For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.

## 8.4. TEST RESULT

The test modes were carried out for all modes.



## LINE CONCUTED EMISSION TEST-L



## MEASUREMENT RESULT: "agc\_fin"

2/7/26 22:4 Frequency MHz		Transd dB	Limit dBµV	Margin dB	Detector	Line
0.586000 0.842000	38.40 26.50	5.4 5.4		17.6 29.5	_	L1 L1
1.106000	26.20	5.6	56	29.8	QP	L1
1.298000	27.60	5.8	56	28.4	QP	L1
	26.60	6.2		29.4	QP	L1
2.294000	26.90	6.5	56	29.1	QP	L1

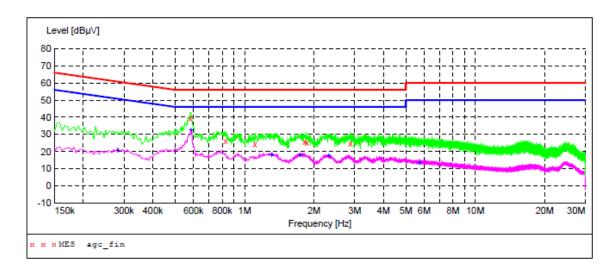
## MEASUREMENT RESULT: "agc fin2"

202	22/7/26 22: Frequency MHz		Transd dB	Limit dBµV	Margin dB	Detector	Line
	0.282000 0.586000 0.918000 2.306000 5.226000 24.638000	20.70 33.30 17.60 16.70 13.70 17.40	6.1 5.4 5.4 6.5 6.6 9.1	51 46 46 46 50 50	30.1 12.7 28.4 29.3 36.3 32.6	AV AV AV	L1 L1 L1 L1 L1 L1

#### **RESULT: PASS**



## LINE CONCUTED EMISSION TEST-N



## MEASUREMENT RESULT: "agc\_fin"

2022/7/26 23 Frequency MHz	Level	Transd dB		Margin dB	Detector	Line
0.582000 0.826000 1.110000 1.818000 1.862000	24.20 25.70	5.4 5.6 6.3 6.4 6.5	56 56 56	30.3	QP QP QP QP	N N N N

## MEASUREMENT RESULT: "agc\_fin2"

2/7/26 22:4 Trequency MHz		Transd dB	Limit dBµV	Margin dB	Detector	Line
0.282000 0.586000 1.310000 1.738000 2.322000 5.718000	20.80 32.70 18.30 18.10 17.60 13.80	6.1 5.4 5.8 6.3 6.5 6.6	51 46 46 46 46 50	13.3 27.7 27.9 28.4	AV AV AV	N N N N N

#### **RESULT: PASS**



Page 24 of 49

## 9. HARMONIC CURRENT MEASUREMENT

## 9.1. LIMITS OF HARMONIC CURRENT

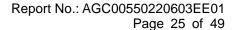
Limits for Class A Equipment					
Harmonics Order n	Max. permissible harmonic current (A)				
Odd ha	armonics				
3	2.30				
5	1.14				
7	0.77				
9	0.40				
11	0.33				
13	0.21				
15≤n≤39	0.15×15/n				
Even h	armonics				
2	1.08				
4	0.43				
6	0.30				
8≤n≤40	0.23×8/n				

Note: 1. According to section 5 of EN61000-3-2: 2014, the EUT is Class A equipment.

2. The above limits are for all applications having an active input power>75W. No limits apply for equipment with an active input power up to and including 75W.

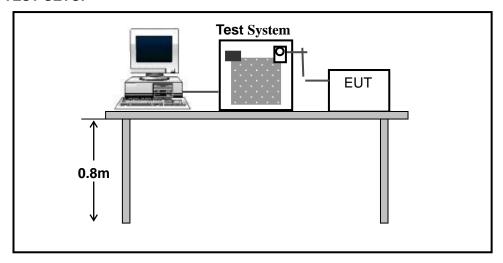
## 9.2. TEST PROCEDURE

- 1. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- 2. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the necessary for the EUT to be exercised.





## 9.3. TEST SETUP



For the actual test configuration, please refer to Appendix I: Photographs of the Test Configuration.

## 9.4. TEST RESULT

No applicable for equipment with an active input power up to and including 75W.



Page 26 of 49

## 10. VOLTAGE FLUCTUATIONS AND FLICK MEASUREMENT

## 10.1. LIMITS OF VOLTAGE FLUCTUATIONS AND FLICK

Test Item Limit		Note
P <sub>st</sub>	1.0	P <sub>st</sub> means Short-term flicker indicator
P <sub>lt</sub>	0.65	P <sub>lt</sub> means long-term flicker indicator
T <sub>dt</sub>	0.5	T <sub>dt</sub> means maximum time that d <sub>t</sub> exceeds 3.3%
d <sub>max</sub> (%)	4%	d <sub>max</sub> means maximum relative voltage change.
d <sub>c</sub> (%)	3.3%	d <sub>c</sub> means relative steady-state voltage change.

#### **10.2. TEST PROCEDURE**

- 1. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal conditions
- 2. During the flick measurement, the measure time shall include that part of whole operation changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

## 10.3. TEST SETUP

Same as 9.3

## 10.4. TEST RESULT

## **Test Specification**

Test Frequency	50Hz	Test Voltage	230V AC
Waveform	Sine	Test Time	10 minutes(P <sub>st</sub> ); 2 hours (P <sub>lt</sub> )

#### **Test Result**

Test Parameter	Measurement Value	Limit	Remarks
P <sub>st</sub>	0.160	1.0	Pass
P <sub>lt</sub>	0.070	0.65	Pass
$T_{dt(s)}$	0.0	0.5	Pass
d <sub>max</sub> (%)	0.00%	4%	Pass
d <sub>c</sub> (%)	0.00%	3.3%	Pass



Page 27 of 49

#### 11. IMMUNITY TEST

## 11.1. DESCRIPTION OF PERFORMANCE CRITERIA

The performance criteria are used to take a decision on whether a radio equipment passes or fails immunity tests.

For the purpose of the present document two categories of performance criteria apply:

- Performance criteria for continuous phenomena.
- Performance criteria for transient phenomena.

## 11.2. GENERAL PERFORMANCE CRITERIA

## 1. Performance criteria for continuous phenomena

During the test, the equipment shall:

- continue to operate as intended;
- · not unintentionally transmit;
- not unintentionally change its operating state;
- · not unintentionally change critical stored data.

## 2. Performance criteria for transient phenomena

For all ports and transient phenomena with the exception described below, the following applies:

- The application of the transient phenomena shall not result in a change of the mode of operation (e.g. unintended transmission) or the loss of critical stored data.
- After application of the transient phenomena, the equipment shall operate as intended.

For surges applied to symmetrically operated wired network ports intended to be connected directly to outdoor lines the following criteria applies:

- For products with only one symmetrical port intended for connection to outdoor lines, loss of function is allowed, provided the function is self-recoverable, or can be otherwise restored. Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.
- For products with more than one symmetrical port intended for connection to outdoor lines, loss of function on the port under test is allowed, provided the function is self-recoverable. Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

For a 0 % residual voltage dip tests the following performance criteria apply:

• The performance criteria for transient phenomena shall apply.

For a 70 % residual voltage dip and voltage interruption tests, the following performance criteria apply:

- in the case where the equipment is fitted with or connected to a battery back-up, the performance criteria for transient phenomena shall apply;
- in the case where the equipment is powered solely from the AC mains supply (without the use of a parallel battery back-up) volatile user data may have been lost and if applicable the communication link need not to be maintained and lost functions should be recoverable by user or operator;
- no unintentional responses shall occur at the end of the test, when the voltage is restored to nominal;
- in the event of loss of function(s) or in the event of loss of user stored data, this fact shall be recorded.



Page 28 of 49

#### 5. Performance Table

	EN 301 489-17 Performance criteria					
Criteria	During Test	After Test (i.e. as a result of the application of the test)				
A	Shall operate as intended. (see note). Shall be no loss of function. Shall be no unintentional transmissions.	Shall operate as intended. Shall be no degradation of performance. Shall be no loss of function. Shall be no loss of critical stored data.				
В	May be loss of function.	Functions shall be self-recoverable. Shall operate as intended after recovering. Shall be no loss of critical stored data.				
С	May be loss of function.	Functions shall be recoverable by the operator. Shall operate as intended after recovering. Shall be no loss of critical stored data.				

The performance criteria A shall apply for continuous phenomena.

The performance criteria B shall apply for transient phenomena, except for voltage dips greater than or equal to 100 ms and voltage interruptions of 5 000 ms duration, for which performance criteria C shall apply.

Where the EUT is a transmitter in standby mode or receive mode, unintentional transmission shall not occur during the test.

Note: Operate as intended during the test allows a level of degradation in accordance with the Minimum performance level.

## Minimum performance level

For equipment that supports a PER or FER, the minimum performance level shall be a PER or FER less than or equal to 10 %.

For equipment that does not support a PER or a FER, the minimum performance level shall be no loss of the wireless transmission function needed for the intended use of the equipment.



Page 29 of 49

## 12. ELECTROSTATIC DISCHARGE IMMUNITY TEST

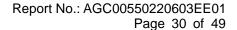
#### 12.1 TEST SPECIFICATION

Basic Standard	EN 61000-4-2	
Discharge Impedance	330Ω / 150 pF	
Discharge Voltage	Air Discharge –8 kV, Contact Discharge – 4 kV	
Polarity	Positive / Negative	
Number of Discharge	Minimum 20 times at each test point	
Discharge Mode	ischarge Mode Single discharge	
Discharge Period	1-second minimum	

#### **12.2 TEST PROCEDURE**

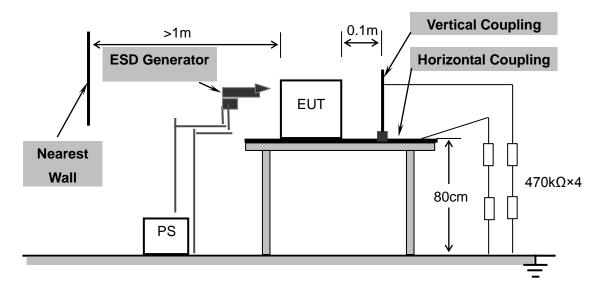
The test procedure was in accordance with EN 61000-4-2:

- a. Electrostatic discharges were applied only to those points and surfaces of the EUT that are accessible to users during normal operation.
- b. The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
- c. The time interval between two successive single discharges was at least 1 second.
- d. The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the EUT.
- e. Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- f. Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were completed.
- g. At least ten single discharges (in the most sensitive polarity) were applied to the Horizontal Coupling Plane at points on each side of the EUT. The ESD generator was positioned vertically at a distance of 0.1 meters from the EUT with the discharge electrode touching the HCP.
- h. At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the Vertical Coupling Plane in sufficiently different positions that the four faces of the EUT were completely illuminated. The VCP (dimensions 0.5m×0.5m) was placed vertically to and 0.1 meters from the EUT.





## 12.3 TEST SETUP



For the actual test configuration, please refer to Appendix A: Photographs of the Test Configuration.

## 12.4 TEST RESULT DESCRIPTION OF THE ELECTROSTATIC DISCHARGES (ESD)

Times of Discharge	Voltage	Coupling	Test Mode	Performance criteria
Mini 25 / Point	±2kV; ±4kV	Contact discharge	Mode 1/2	А
Mini 25 / Point	±2kV; ±4kV; ±8kV	Air Discharge	Mode 1/2	Α
Mini 25 / Point	±4kV	Indirect Discharge HCP	Mode 1/2	А
Mini 25 / Point	±4kV	Indirect Discharge VCP	Mode 1/2	А
A: No degradation in the performance of the FLIT was observed				

A: No degradation in the performance of the EUT was observed.



Page 31 of 49

**ESD** location:

Blue line: Air discharge Red line: Contact discharge





Page 32 of 49

## **12.5 PERFORMANCE**

⊠Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
☐Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
☐Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

<b>⊠</b> PASS	□FAIL



Page 33 of 49

## 13. RADIATED, RADIO FREQUENCY ELECTROMAGNETIC FIELD IMMUNITY TEST 13.1. TEST SPECIFICATION

10.11. TEST OF ESTITION				
Basic Standard	EN 61000-4-3			
Frequency Range	80 MHz – 6000MHz			
Field Strength	3V/m			
Modulation	1 kHz sine wave, 80%, AM modulation			
Frequency Step	1% of fundamental			
Polarity of Antenna	Horizontal and Vertical			
Test Distance	3m			
Antenna Height	ntenna Height 1.55m			
Dwell Time	3 seconds			

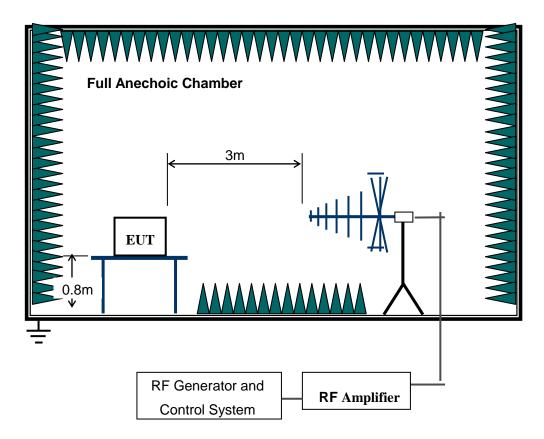
## 13.2. TEST PROCEDURE

The test procedure was in accordance with EN 61000-4-3.

- a. The testing was performed in a fully anechoic chamber. The transmit antenna was located at a distance of 3 meters from the EUT.
- b. The test signal was 80% amplitude modulated with a 1 kHz sine wave.
- c. The frequency range was swept from 80 MHz to 6000MHz with the exception of the exclusion band for transmitters, receivers and duplex transceivers. The rate of sweep did not exceed 1.5×10<sup>-3</sup> decade/s. Where the frequency range is swept incrementally, the step size was 1% of fundamental.
- d. The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- e. The field strength level was 3V/m.
- f. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.



## 13.3. TEST SETUP



For the actual test configuration, please refer to Appendix A: Photographs of the Test Configuration.



Page 35 of 49

## 13.4. TEST RESULT

Freq. Range (MHz)	Field	Modulation	Polarity	Position	Test Mode	Performance criteria
80-6000	3V/m	Yes	Н	Front	Mode 1/2	А
80-6000	3V/m	Yes	Н	Back	Mode 1/2	А
80-6000	3V/m	Yes	Н	Left	Mode 1/2	А
80-6000	3V/m	Yes	Н	Right	Mode 1/2	А
80-6000	3V/m	Yes	V	Front	Mode 1/2	А
80-6000	3V/m	Yes	V	Back	Mode 1/2	А
80-6000	3V/m	Yes	V	Left	Mode 1/2	А
80-6000	3V/m	Yes	V	Right	Mode 1/2	А
		A. No degree detion or DED at 400% in the professioner of the ELIT was absented				

A: No degradation or PER < 10% in the performance of the EUT was observed.

## 13.5. PERFORMANCE

⊠Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
□Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
□Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

⊠PAS	22	FAIL	
⊠r Ac		J <i>i AIL</i>	



## 14. ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST

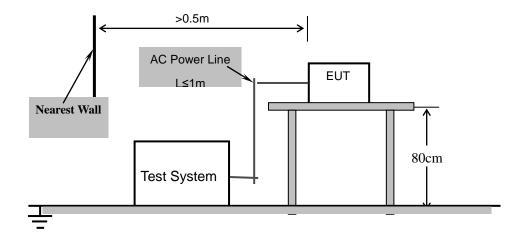
## 14.1. TEST SPECIFICATION

Basic Standard	EN 61000-4-4
Test Voltage	a.c. power port – 1 kV
Polarity	Positive/Negative
Impulse Frequency	5kHz
Impulse wave shape	5/50ns
<b>Burst Duration</b>	15ms
Burst Period	300ms
Test Duration	Not less than 1 min.

#### 14.2. TEST PROCEDURE

- 1. The EUT was tested with 1000 volt discharges to the AC power input leads.
- 2. Both positive and negative polarity discharges were applied.
- 3. The length of the "hot wire" from the coaxial output of the EFT generator to the terminals on the EUT should not exceed 1 meter.
- 4. The duration time of each test sequential was 1 minute.
- 5. The transient/burst waveform was in accordance with IEC 61000-4-4, 5/50ns.

## 14.3. TEST SETUP



For the actual test configuration, please refer to Appendix A: Photographs of the Test Configuration.



Page 37 of 49

### 14.4. TEST RESULT

Test Point	Polarity	Test Level (kV)	Test Mode	Performance criteria
a.c. port, L	+/-	1	Mode 1	А
a.c. port, N	+/-	1	Mode 1	А
a.c. port, L-N	+/-	1	Mode 1	А
A: No degradation in the r	erformance of th	a FLIT was observed		

A: No degradation in the performance of the EUT was observed.

# 14.5. PERFORMANCE

⊠Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
☐Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
☐Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

M DACC		
IXI <i>PA</i> SS	∟  <i>FAIL</i>	
	_	



## 15. SURGE IMMUNITY TEST

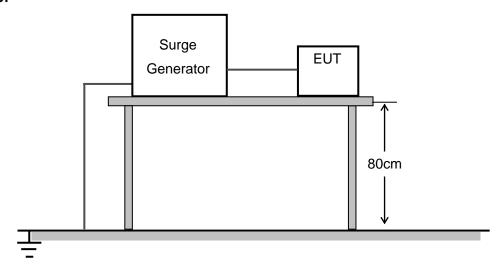
### 15.1. TEST SPECIFICATION

Basic Standard	EN 61000-4-5
Waveform	Voltage 1.2/50 μs; Current 8/20 μs
Test Voltage	a.c. power port, line to line 1.0 kV
Polarity	Positive/Negative
Phase Angle	0°, 90°, 180°, 270°
Repetition Rate	60sec
Times	5 time/each condition.

#### 15.2. TEST PROCEDURE

- a. The EUT and the auxiliary equipment were placed on a table of 0.8m heights above a metal ground reference plane. The size of ground plane is greater than 1m×1m and project beyond the EUT by at least 0.1m on all sides. The ground plane is connected to the protective earth. The length of power cord between the coupling device and the EUT was less than 2 meters (provided by the manufacturer).
- b. The EUT was connected to the power mains through a coupling device that directly couples the surge interference signal. The surge noise was applied synchronized to the voltage phase at the zero crossing and the peak value of the AC voltage wave (positive and negative).
- c. The surges were applied line to line and line(s) to earth. All lower levels including the selected test level were tested. The polarity of each surge level included positive and negative test pulses.

## 15.3. TEST SETUP



For the actual test configuration, please refer to Appendix A: Photographs of the Test Configuration.



Page 39 of 49

### 15.4. TEST RESULT

Coupling Line	Polarity	Voltage (kV)	Test Mode	Performance criteria
a.c. power, L-N	+/-	1.0	Mode 1	А
A: No degradation in the performance of the EUT was observed.				

# 15.5. PERFORMANCE

Criteria A:	function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
☐Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
☐Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

<b>⊠</b> PASS	□FAIL	



## 16. IMMUNITY TO CONDUCTED DISTURBANCES INDUCED BY RF FIELDS

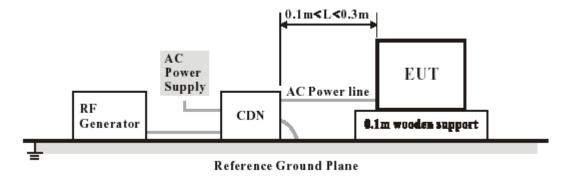
### 16.1. TEST SPECIFICATION

Basic Standard	EN 61000-4-6
Frequency Range	0.15 MHz – 80 MHz
Field Strength	3Vrms
Modulation	1 kHz Sine Wave, 80% AM
Frequency Step	1% of fundamental
Coupled Cable	a.c. power line
Coupling Device	CDN-M2

#### 16.2. TEST PROCEDURE

- 1. The EUT shall be tested within its intended operating and climatic conditions.
- 2. The test shall be performed with the test generator connected to each of the coupling and decoupling devices in turn, while the other non-excited RF input ports of the coupling devices are terminated by a 50-ohm load resistor.
- 3. The test signal was 80% amplitude modulated with a 1 kHz sine wave
- 4. The frequency range is swept from 150 kHz to 80 MHz, using the signal level established during the setting process and with a disturbance signal of 80% amplitude. The sweep rate shall not exceed 1.5×10-3 decades/s. The step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value where the frequency is swept incrementally.
- The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised, and able to respond. Sensitive frequencies such as clock frequencies and harmonics or frequencies of dominant interest, shall be analyzed separately.
- 6. Attempts should be made to fully exercise the EUT during test, and to fully interrogate all exercise modes selected for susceptibility.

#### 16.3. TEST SETUP



For the actual test configuration, please refer to Appendix A: Photographs of the Test Configuration.



Page 41 of 49

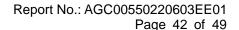
### 16.4. TEST RESULT

Test Point	Frequency (MHz)	Level (V rms)	Test Mode	Performance criteria
a.c. port	0.15 – 80	3	Mode 1	А
A: No degradation in the performance of the EUT was observed.				

# **16.5. PERFORMANCE**

⊠Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
□Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
☐Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.
	restored by the operation of controls.

<b>⊠</b> PASS	□FAIL	





17. VOLTAGE DIPS AND SHORT INTERRUPTIONS IMMUNITY TEST

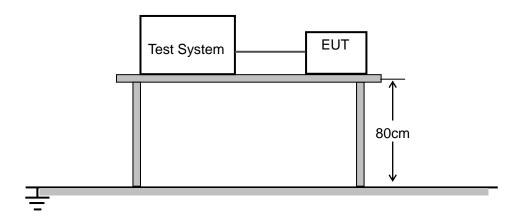
### 17.1. TEST SPECIFICATION

Basic Standard	EN 61000-4-11
	100% reduction, 0.5 Cycle
Voltage Dips	100% reduction, 1.0 Cycle
	30% reduction, 25 Cycles
Voltage Interruptions	100% reduction, 250 Cycles
Voltage Phase Angle	0°, 45°, 90°, 135°, 180°, 225°, 270°, 315°

#### 17.2. TEST PROCEDURE

- a). The power cord was used as supplied by the manufacturer. The EUT was connected to the line output of the Voltage Dips and Interruption Generator.
- b). The EUT was tested for (1) 100% voltage dip of supplied voltage with duration of 0.5 cycles, (2)100% voltage dip of supplied voltage and duration 1.0 cycle. (3) 30% voltage dip of supplied voltage and duration 25 cycles. (4) 100% voltage interruption of supplied voltage with duration of 250 Cycles was followed.
- c). Voltage reductions occur at 0 degree crossover point of the voltage waveform. The performance of the EUT was checked after the voltage dip or interruption.

### 17.3. TEST SETUP



For the actual test configuration, please refer to Appendix A, Photographs of the Test Configuration.



Page 43 of 49

### 17.4. TEST RESULT

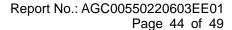
Test Mode	Voltage Reduction	Duration (cycle)	Times	Interval (Sec)	Test Mode	Performance criteria
Voltage dips	100%	0.5	3	10	Mode 1	В
	100%	1	3	10	Mode 1	В
	30%	25	3	10	Mode 1	В
Voltage interruptions	100%	250	3	10	Mode 1	С

- A: No degradation in the performance of the EUT was observed.
- B: Stop charging during the test and self-recoverable after test.
- C: Lost functions can be recoverable by user or operator.

#### 17.5. PERFORMANCE

☐Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
⊠Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
⊠Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

⊠ <i>PASS</i> □ <i>FAIL</i>
-----------------------------



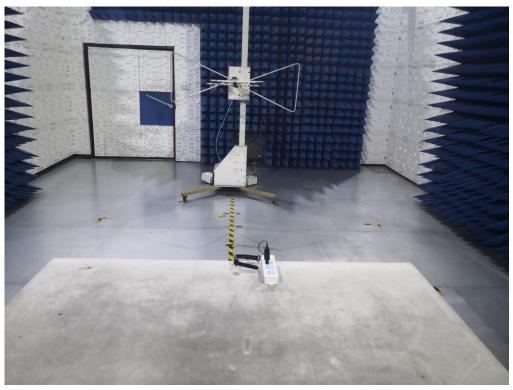


# APPENDIX A: PHOTOGRAPHS OF TEST SETUP

LINE CONDUCTED EMISSION TEST SETUP

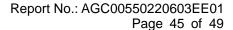


RADIATED EMISSION TEST SETUP (BELOW 1GHz)



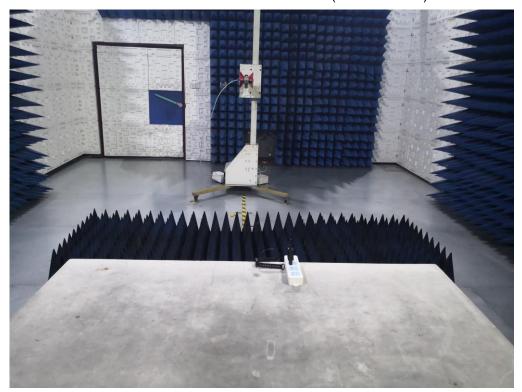
Any report having not been signed by authorized approver, or having been altered without authorization, or having not been stamped by the "Dedicated Testing/Inspection Stamp" is deemed to be invalid. Copying or excerpting portion of, or altering the content of the report is not permitted without the written authorization of AGC. The test results presented in the report apply only to the tested sample. Any objections to report issued by AGC should be submitted to AGC within 15days after the issuance of the test report. Further enquiry of validity or verification of the test report should be addressed to AGC by agc01@agccert.com.

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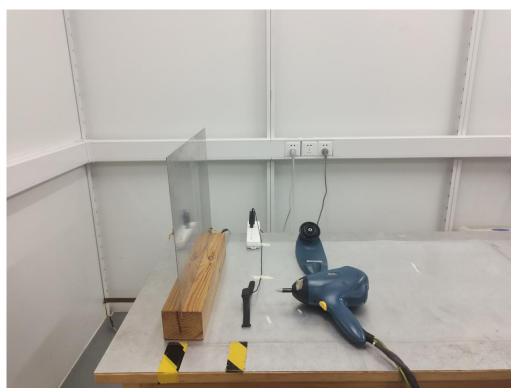


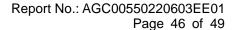


# RADIATED EMISSION TEST SETUP (ABOVE 1GHz)



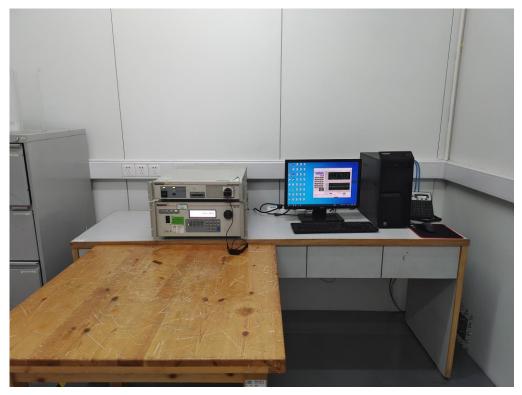
EN 61000-4-2 ESD TEST SETUP



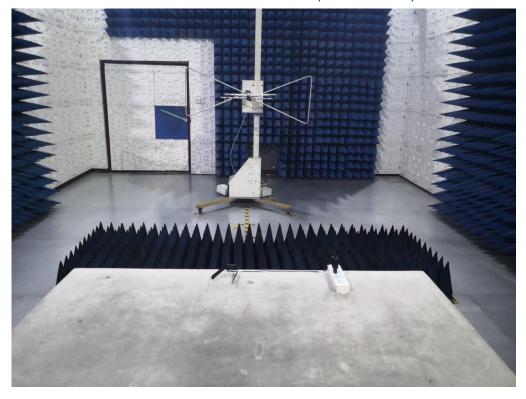


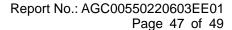


# EN61000-3-3 VOLTAGE FLUCTUATION / FLICKER TEST SETUP



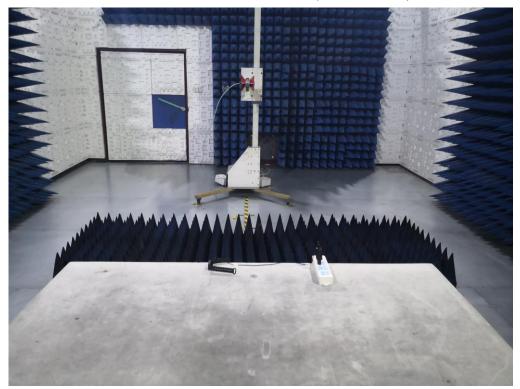
EN 61000-4-3 RS TEST SETUP (BELOW 1GHz)







# EN 61000-4-3 RS TEST SETUP (ABOVE 1GHz)

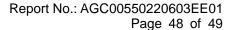


EN 61000-4-6 CS IMMUNITY TEST SETUP



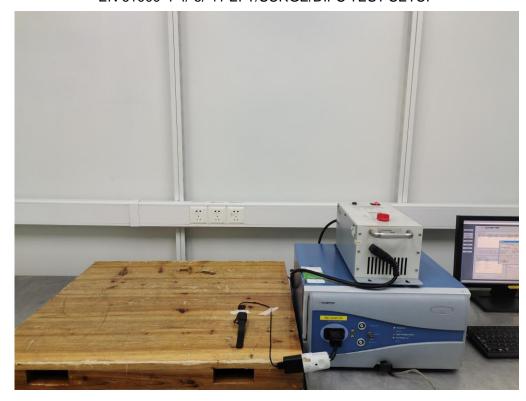
Any report having not been signed by authorized approver, or having been altered without authorization, or having not been stamped by the "Dedicated Testing/Inspection Stamp" is deemed to be invalid. Copying or excerpting portion of, or altering the content of the report is not permitted without the written authorization of AGC. The test results presented in the report apply only to the tested sample. Any objections to report issued by AGC should be submitted to AGC within 15days after the issuance of the test report. Further enquiry of validity or verification of the test report should be addressed to AGC by agc01@agccert.com.

Tel: +86-755 2523 4088 E-mail: agc@agccert.com Web: http://www.agccert.com/





# EN 61000-4-4/-5/-11 EFT/SURGE/DIPS TEST SETUP





Page 49 of 49

# **APPENDIX B: PHOTOGRAPHS OF EUT**

Refer to the Report No.: AGC00550220603AP01

----END OF REPORT----



# Conditions of Issuance of Test Reports

- 1. All samples and goods are accepted by the Attestation of Global Compliance (Shenzhen) Co., Ltd. (the "Company") solely for testing and reporting in accordance with the following terms and conditions. The company provides its services on the basis that such terms and conditions constitute express agreement between the company and any person, firm or company requesting its services (the "Clients").
- 2. Any report issued by Company as a result of this application for testing services (the "Report") shall be issued in confidence to the Clients and the Report will be strictly treated as such by the Company. It may not be reproduced either in its entirety or in part and it may not be used for advertising or other unauthorized purposes without the written consent of the Company. The Clients to whom the Report is issued may, however, show or send it, or a certified copy thereof prepared by the Company to its customer, supplier or other persons directly concerned. The Company will not, without the consent of the Clients, enter into any discussion or correspondence with any third party concerning the contents of the Report, unless required by the relevant governmental authorities, laws or court orders.
- 3. The Company shall not be called or be liable to be called to give evidence or testimony on the Report in a court of law without its prior written consent, unless required by the relevant governmental authorities, laws or court orders.
- 4. In the event of the improper use of the report as determined by the Company, the Company reserves the right to withdraw it, and to adopt any other additional remedies which may be appropriate.
- 5. Samples submitted for testing are accepted on the understanding that the Report issued cannot form the basis of, or be the instrument for, any legal action against the Company.
- 6. The Company will not be liable for or accept responsibility for any loss or damage however arising from the use of information contained in any of its Reports or in any communication whatsoever about its said tests or investigations.
- 7. Clients wishing to use the Report in court proceedings or arbitration shall inform the Company to that effect prior to submitting the sample for testing.
- 8. The Company is not responsible for recalling the electronic version of the original report when any revision is made to them. The Client assumes the responsibility to providing the revised version to any interested party who uses them.
- 9. Subject to the variable length of retention time for test data and report stored hereinto as otherwise specifically required by individual accreditation authorities, the Company will only keep the supporting test data and information of the test report for a period of six years. The data and information will be disposed of after the aforementioned retention period has elapsed. Under no circumstances shall we provide any data and information which has been disposed of after retention period. Under no circumstances shall we be liable for damage of any kind, including (but not limited to) compensatory damages, lost profits, lost data, or any form of special, incidental, indirect, consequential or punitive damages of any kind, whether based on breach of contract of warranty, tort (including negligence), product liability or otherwise, even if we are informed in advance of the possibility of such damages.